

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/880,734	CROSLAND ET AL.	
Examiner	Art Unit	
Tse Chen	2116	

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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